

DIM400PHM17-A000

Half Bridge IGBT Module

DS5561-1.2 JULY 2005 (LN24089)

FEATURES

- 10µs Short Circuit Withstand
- · High Thermal Cycling Capability
- Non Punch Through Silicon
- Isolated MMC Base with AIN Substrates
- 6kV Isolation Voltage
- Lead Free Construction

APPLICATIONS

- Motor Drives
- High Reliability Inverters
- Traction Inverters

The Powerline range of high power modules includes half bridge, chopper, dual, single and bidirectional switch configurations covering voltages from 600V to 3300V and currents up to 3600A.

The DIM400PHM17-A000 is a half bridge 1700V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full $10\mu s$ short circuit withstand. This module is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM400PHM17-A000

Note: When ordering, please use the whole part number.

KEY PARAMETERS

V _{CES}		1700V
V _{CE (sat)} *	(typ)	2.7V
Ic	(max)	400A
I _{C(PK)}	(max)	800A

^{* (}measured at the power busbars and not the auxiliary terminals)

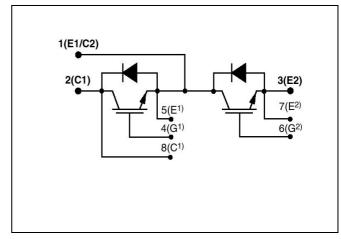


Fig. 1 Half Bridge circuit diagram

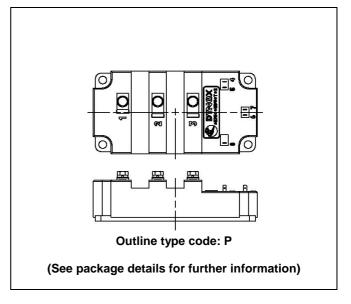


Fig. 2 Module Outline



ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

Tcase = 25° C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	1700	V
V _{GES}	Gate-emitter voltage		±20	V
Ic	Continuous collector current	T _{case} = 75° C	400	Α
I _{C(PK)}	Peak collector current	1ms, T _{case} =110° C	800	Α
P _{max}	Max. transistor power dissipation	T _{case} = 25° C, T _j = 150° C	3470	W
l ² t	Diode I ² t value (IGBT arm)	$V_R = 0$, $t_P = 10$ ms, $T_{\nu j} = 125$ ° C	30	kA ² S
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
Q_{PD}	Partial discharge – per module	IEC1287. V ₁ = 3500V, V ₂ = 2600V, 50Hz RMS	10	рС



THERMAL AND MECHANICAL RATINGS

Internal insulation material: ALN
Baseplate material: AISiC
Creepage distance: 33mm
Clearance: 20mm
CTI (Critical Tracking Index): 175

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
R _{th(j-c)}	Thermal resistance – transistor (per arm)	Continuous dissipation – junction to case	-	-	36	° C/kW
R _{th(j-c)}	Thermal resistance – diode (per arm)	Continuous dissipation – junction to case	-	-	80	° C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	16	° C/kW
Tj	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
-	Screw torque	Mounting – M6	-	-	5	Nm
	·	Electrical connections – M5	-	-	4	Nm



ELECTRICAL CHARACTERISTICS

T_{case} = 25° C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
I _{ces}	Collector cut-off current	V _{GE} = 0V, V _{CE} = V _{CES}	-	-	1	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 125° C	-	-	12	mA
I _{ces}	Gate leakage current	$V_{GE} = \pm 20V$, $V_{CE} = 0V$	-	-	2	nA
V _{GE(TH)}	Gate threshold voltage	$I_C = 16mA$, $V_{GE} = V_{CE}$	4.5	5.5	6.5	V
V _{CE(sat)} ⁺	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 400A	-	2.7	3.2	V
		V _{GE} = 15V, I _C = 400A, T _{case} = 125° C	-	3.4	4.0	V
I _F	Diode forward current	DC	-	-	400	Α
I _{FM}	Diode maximum forward current	t _p = 1ms	-	-	800	Α
V _F †	Diode forward voltage	I _F = 400A	-	2.2	2.5	V
		I _F = 400A, T _{case} = 125° C	-	2.3	2.6	V
C _{ies}	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz	-	30	-	nF
L _M	Module inductance- per arm	-	-	20	-	nH
R _{INT}	Internal resistance- per arm	-	-	0.27	-	mΩ
SC _{Data}	Short circuit. I _{sc}	$T_j = 125^{\circ} \text{ C}, V_{cc} = 1000 \text{ V},$ I_1	-	1850	-	Α
		$\begin{aligned} t_p &\leq 10 \mu s, \\ V_{CE(max)} &= V_{CES} - L^*.di/dt \end{aligned}$ IEC 60747-9	-	1600	-	A

Note:

⁺ Measured at the auxiliary terminals

 $^{^{\}ast}$ L is the circuit inductance + L_{M}



ELECTRICAL CHARACTERISTICS

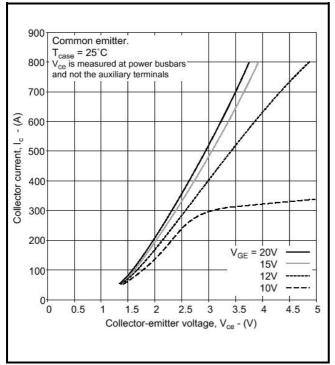
 T_{case} = 25° C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t _{d(off)}	Turn-off delay time	I _C = 400A	-	1150	-	ns
t _f	Fall time	V _{GE} = ±15V	-	100	-	ns
E _{OFF}	Turn-off energy loss	V _{CE} = 900V	-	120	-	mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 4.7\Omega$	-	250	-	ns
t _r	Rise time	L ~ 100nH	-	250	-	ns
Eo	Turn-on energy loss		-	150	-	mJ
Q_g	Gate charge		-	4.5	-	μC
Q _{rr}	Diode reverse recovery charge	I _F = 400A, V _R = 900V,	-	100	-	μC
I _{rr}	Diode reverse current	dl _F /dt = 3000A/µs	-	230	-	Α
E _{REC}	Diode reverse recovery energy		-	70	-	mJ

T_{case} = 125° C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t _{d(off)}	Turn-off delay time	I _C = 400A	-	1400	-	ns
t _f	Fall time	V _{GE} = ±15V	-	130	-	ns
E _{OFF}	Turn-off energy loss	V _{CE} = 900V	-	180	-	mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 4.7\Omega$	-	400	-	ns
t _r	Rise time	L ~ 100nH	-	250	-	ns
Eon	Turn-on energy loss		-	170	-	mJ
Q _{rr}	Diode reverse recovery charge	I _F = 400A, V _R = 900V,	-	170	-	μC
Irr	Diode reverse current	dl _F /dt = 2500A/µs	-	270	-	Α
E _{REC}	Diode reverse recovery energy		-	100	-	mJ





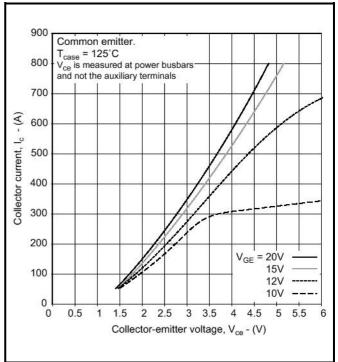
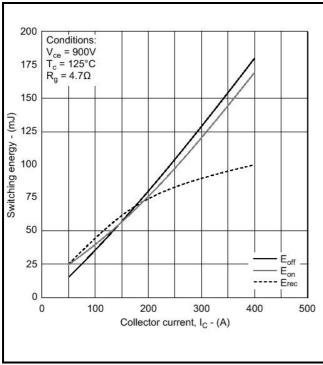
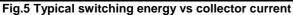


Fig.3 Typical output characteristics

Fig.4 Typical output characteristics





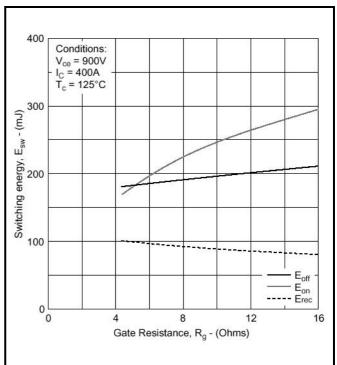
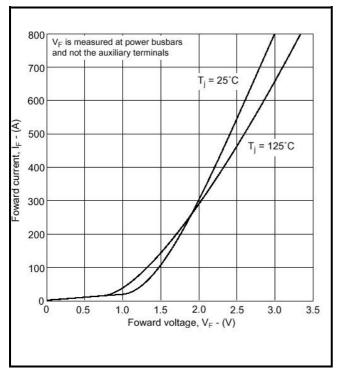


Fig.6 Typical switching energy vs gate resistance





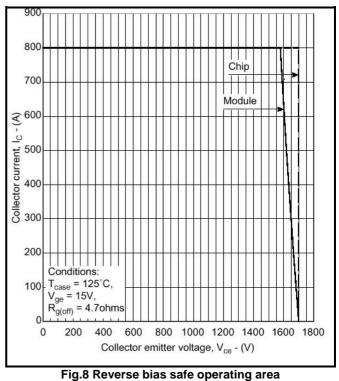
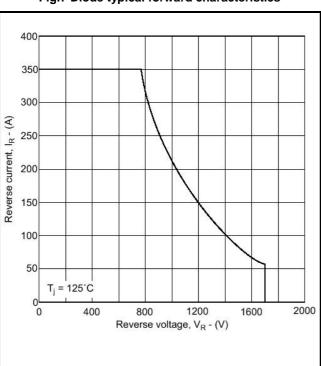


Fig.7 Diode typical forward characteristics



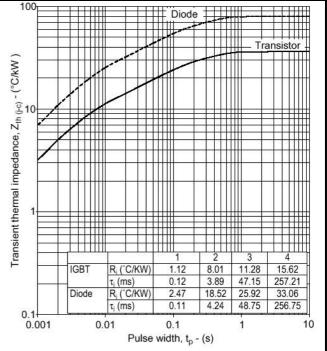


Fig.9 Diode reverse bias safe operating area

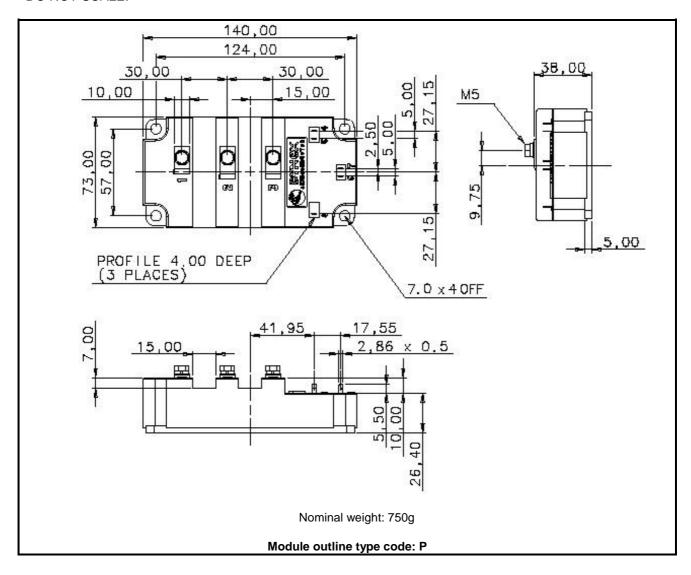
Fig.10 Transient thermal impedance



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DO NOT SCALE.





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We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

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The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

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